Spec.No.IGBT-SP-14002 R6 P 1

MBN500FH65E2

Silicon N-channel IGBT 6500V E2 version

FEATURES

- * Soft switching behavior & low conduction loss: Soft low-injection punch-through High conductivity IGBT.
- * Low driving power due to low input capacitance MOS gate.
- * Low noise recovery: Ultra soft fast recovery diode.
- * High thermal fatigue durability:

AISiC base-plate/AIN substrate

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item	Symbol	Unit	MBN500FH65E2	
	T _{vi} =125°C	-		6,500
Collector Emitter Voltage	T _{vi} =25°C	V _{CES}	V	6,500
	T _{vi} =-40°C]		6,000
Gate Emitter Voltage	•	V_{GES}	V	±20
Collector Current	DC	Ic	A	500
Collector Current	1ms	I _{CRM}	7 ^	1,000
Forward Current	DC	I _F	^	500
Forward Current	1ms	I _{FRM}	A	1,000
Operating Junction Temper	rature	T _{vi op}	°C	-40 ~ +125
Storage Temperature		T _{stg}	°C	-50 ~ +125
Isolation Voltage		V _{ISO}	V _{RMS}	10,200(AC 1 minute)
Sorow Torque	Terminals (M4/M8)	-	N·m	2/10 (1)
Screw Torque	Mounting (M6)	-	111-111	6 (2)

Notes: (1) Recommended Value 1.8±0.2/9±1N·m

(2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions
Collector Emitter Cut-Off Current	lana	mA	-	-	17	V _{CE} =6,500V, V _{GE} =0V, T _{vj} =25°C
	I _{CES}	шл	-	17	67	V _{CE} =6,500V, V _{GE} =0V, T _{vj} =125°C
Gate Emitter Leakage Current	I _{GES}	nΑ	-500	•	+500	$V_{GE}=\pm 20V, V_{CE}=0V, T_{vj}=25^{\circ}C$
Collector Emitter Saturation Voltage	1/0-	V	-	3.2	-	I _C =500A, V _{GE} =15V, T _{vj} =25°C
Collector Emitter Saturation voltage	V _{CEsat}	•	4.0	4.5	5.0	I _C =500A, V _{GE} =15V, T _{vj} =125°C
Gate Emitter Threshold Voltage	V _{GE(th)}	V	5.8	6.3	6.8	V _{CE} =10V, I _C =500mA, T _{Vj} =25°C
Input Capacitance	Cies	nF	-	87	-	$V_{CE}=10V$, $V_{GE}=0V$, $f=100kHz$, $T_{vj}=25^{\circ}C$
Internal Gate Resistance	R _{G(int)}	Ω	-	1.1	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Turn On Delay Time	t _{d(on)}		-	0.7	-	V_{CC} =3,600V, I_{C} =500A
Rise Time	t _r		2.0	3.2	4.8	L _S =210nH
Turn Off Delay Time	t _{d(off)}	μS	-	3.3	-	$R_G=10\Omega$ (3)
Fall Time	t _f		2.1	3.1	4.7	$V_{GE}=\pm 15V, T_{vj}=125^{\circ}C$
Forward Valtage Drop	\/_	V	-	3.6	-	$I_F=500A$, $V_{GE}=0V$, $T_{vj}=25$ °C
Forward Voltage Drop	V _F		3.3	3.9	4.6	I _F =500A, V _{GE} =0V, T _{vj} =125°C
Reverse Recovery Time	t _{rr}	μS	-	0.8	1.6	V _{CC} =3,600V, I _F =500A, L _S =210nH T _{Vi} =125°C
Turn On Loss	E _{on(10%)}	J/P	-	3.2	3.9	
Tulli Oli Loss	E _{on(full)}	J/F	-	3.6	-	V _{CC} =3,600V, I _C =500A, L _S =210nH
Turn Off Loss	E _{off(10%)}	J/P	-	2.6	3.25	$R_{\rm G}=10\Omega$ (3)
Tuill Oil Loss	E _{off(full)}	J/F	-	2.8	-	
Reverse Recovery Loss	E _{rr(10%)}	J/P	-	1.6	2.05	$V_{GE}=\pm 15V, T_{vj}=125^{\circ}C$
Reverse Recovery Loss	E _{rr(full)}	J/F	-	1.7	-	
Short Circuit Pulse Width	t _{sc}	นร	10	_		V _{CC} =4,500V, Ls=210nH
Onort Oncurr uise width	L SC	<u> </u>	10	_		$R_G(on/off)=10/100\Omega$, $V_{GE}=\pm 15V$, $T_{vj}=25^{\circ}C$
Partial discharge extinction voltage	V _e	V_{RMS}	5,100	-	-	f=50Hz, Q _{PD} ≤10pC(acc. to IEC 61287)

Notes: (3) R_G value is a test condition value for evaluation, not recommended value. Please, determine the suitable R_G value by measuring switching behaviors.

^{*} Please contact our representatives at order.

^{*} For improvement, specifications are subject to change without notice.

^{*} For actual application, please confirm this spec sheet is the newest revision.

THERMAL CHARACTERISTICS

Item		Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Thermal Impadence	IGBT	R _{th(j-c)}	K/W	-	-	0.0128	lunation to appo
Thermal Impedance	FWD	R _{th(j-c)}	IN/VV	-	-	0.0255	Junction to case
Contact Thermal Impedance		R _{th(c-f)}	K/W	-	0.007	-	Case to fin (λgrease=1W/(m⋅K), heat-sink flatness ≤50um)

MODULE MECHANICAL CHARACTERISTICS

Item		Unit	Characteristics	Conditions
Weight		g	1,100	
Stray inductance in module	LS(CM-EM)	nΗ	15	Collector-main to Emitter-main
Comparative Tracking Index	(CTI)	-	600	
Module base plate Material		-	Al-SiC	
Baseplate Thickness		mm	5	
Insulation plate Material		-	AI N	
Terminal Surface treatment		-	Ni plating	
Case Material		-	Poly-Phenylene Sulfide	
Fire and Smoke Category		-	I2 / F3	NFF 16-102

DEFINITION OF TEST CIRCUIT

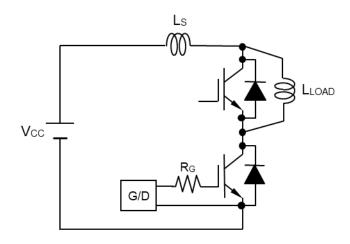


Fig.1 Switching test circuit

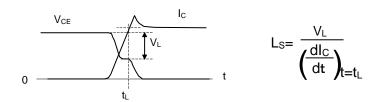


Fig.2 Definition of stray inductance

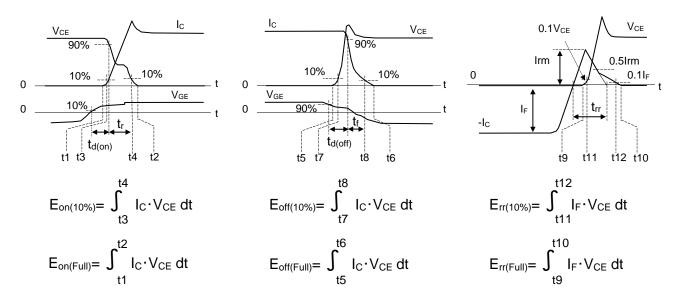
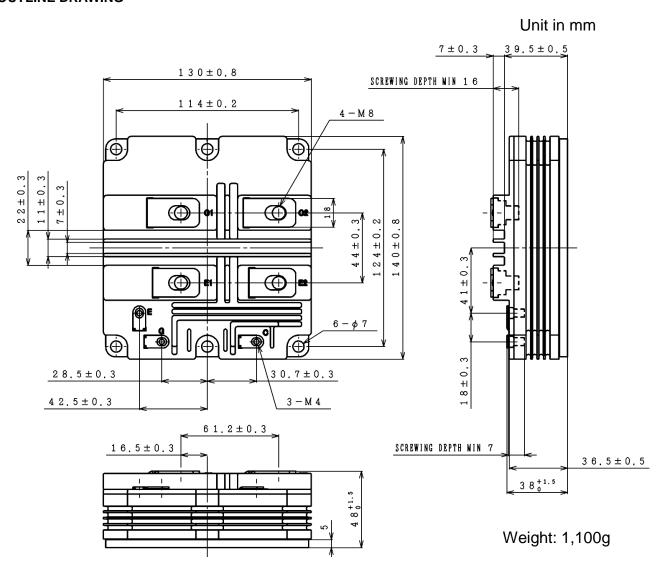
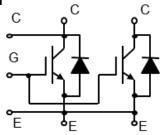


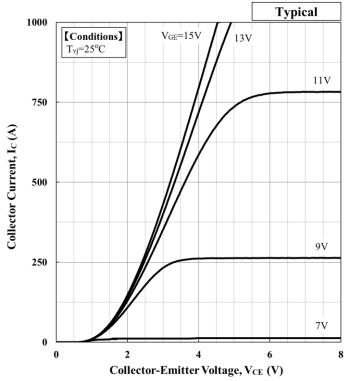
Fig.3 Definition of switching loss

OUTLINE DRAWING



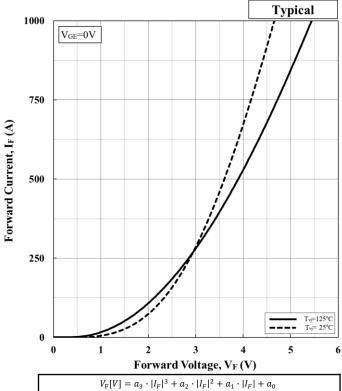
CIRCUIT DIAGRAM





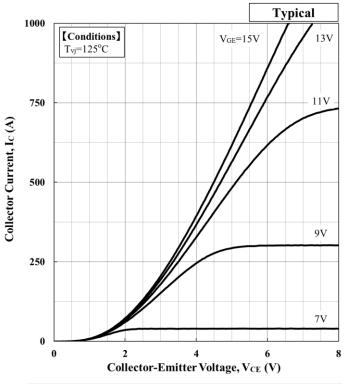
$V_{\text{CE}}(sat)[V] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$							
Temp.[°C]	Temp.[°C] $V_{GE}[V]$ a_3 a_2 a_1 a_3						
25	15	1.98.E-09	-4.22.E-06	5.56.E-03	1.25.E+00		

Collector Current vs. Collector Emitter Voltage



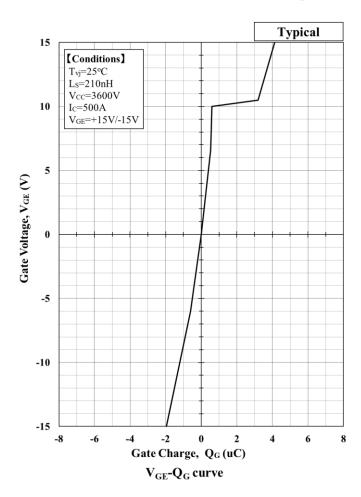
$V_{F}[V] = a_3 \cdot I_F ^3 + a_2 \cdot I_F ^2 + a_1 \cdot I_F + a_0$									
Temp.[°C]	a_3	a_2	a_1	a_0					
25 2.83.E-09		-6.19.E-06	6.47.E-03	1.58.E+00					
125	2.93.E-09	-6.73.E-06	8.10.E-03	1.18.E+00					

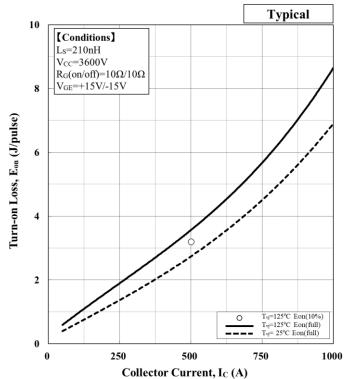
Forward Voltage of free-wheeling diode



$V_{\text{CE}}(sat)[V] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$								
Temp.[°C] $V_{GE}[V]$ a_3 a_2 a_1 a_0								
125	15	3.16.E-09	-6.68.E-06	8.70.E-03	1.43.E+00			

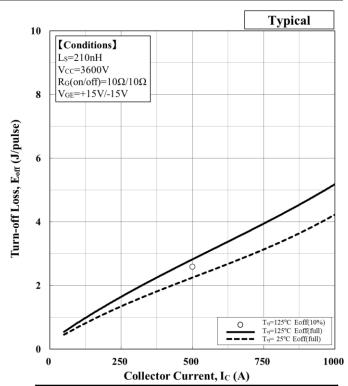
Collector Current vs. Collector Emitter Voltage





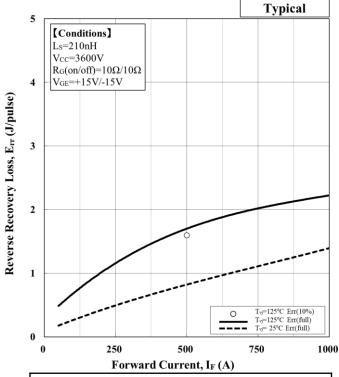
. , ,									
$E[J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$									
Temp.[°C]	a_3	a_2	a_1	a_0					
25	25 2.53.E-09		4.84.E-03	1.57.E-01					
125	4.56.E-09	-3.31.E-06	7.15.E-03	2.45.E-01					

Turn-on loss vs. Collector current



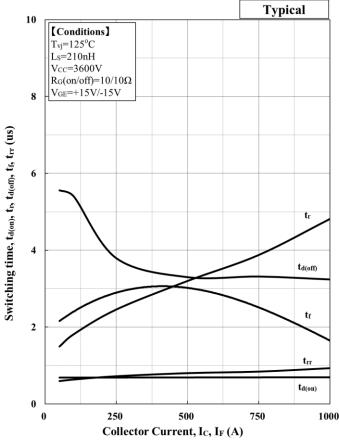
	$E[J] = a_3 \cdot I_c ^3 + a_2 \cdot I_c ^2 + a_1 \cdot I_c + a_0$									
Temp.[°C]	a_3	a_2	a_1	a_0						
25	25 2.46.E-09		5.41.E-03	1.94.E-01						
125	1.83.E-09	-3.17.E-06	6.28.E-03	2.43.E-01						

Turn-off loss vs. Collector current



$E[J] = a_3 \cdot I_F ^3 + a_2 \cdot I_F ^2 + a_1 \cdot I_F + a_0$								
Temp.[°C]	a_3	a_2	a_1	a_0				
25	3.93.E-10	-9.12.E-07	1.82.E-03	8.74.E-02				
125	1.18.E-09	-3.57.E-06	4.33.E-03	2.78.E-01				
		_						

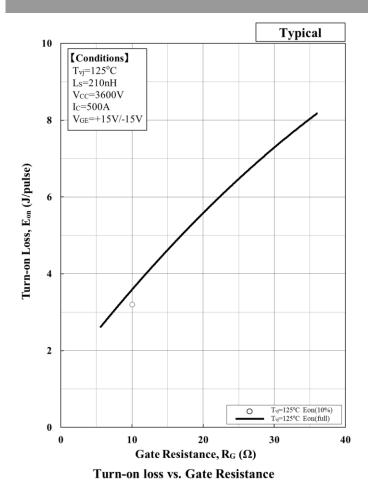
Recovery loss vs. Forward current



Switching time vs. Collector Current

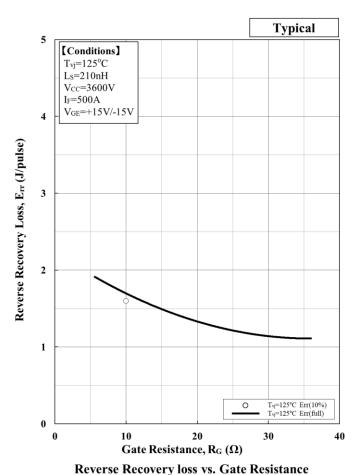
Typical

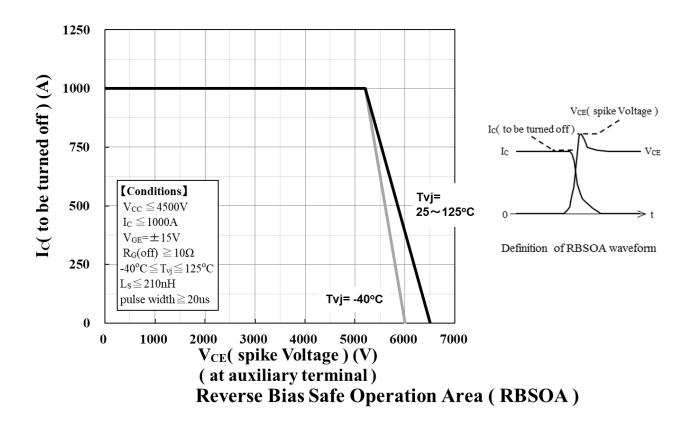
MBN500FH65E2

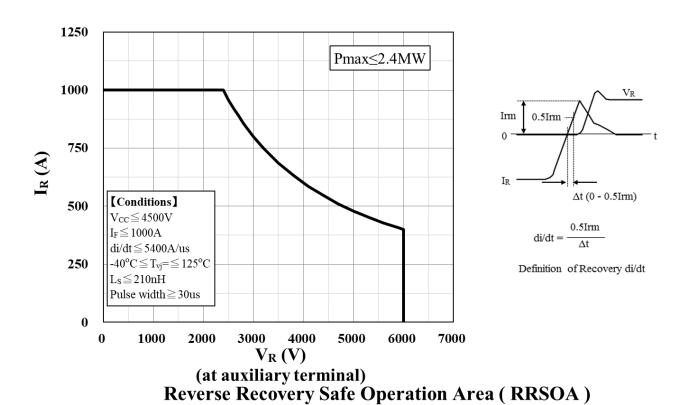


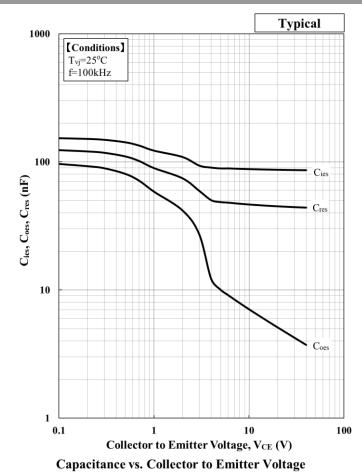
10

[Conditions]









0.1 Diode

| Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | Diode | D

Foster model lumped circuit constant

n	1	2	3	4	Unit
R th, IGBT [n]	7.99E-03	2.53E-03	2.21E-03	6.99E-05	[K/W]
C th, IGBT [n]	2.05E+01	1.09E+01	3.02E+00	1.06E+01	[J/K]
R th, Diode [n]	1.59E-02	5.02E-03	4.42E-03	1.38E-04	[K/W]
C th, Diode [n]	1.03E+01	5.48E+00	1.51E+00	5.38E+00	[J/K]

Transient Thermal Impedance Curve

Cauer model lumped circuit constant

n	1	2	3	4	Unit
R th, IGBT [n]	1.78E-03	2.67E-03	3.98E-03	4.38E-03	[K/W]
C th, IGBT [n]	1.77E+00	8.35E-01	8.14E+00	2.26E+01	[J/K]
R th, Diode [n]	3.55E-03	5.30E-03	7.92E-03	8.73E-03	[K/W]
C th, Diode [n]	8.88E-01	4.18E-01	4.09E+00	1.13E+01	[J/K]

Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

Minebea POWER SEMICONDUCTORS

Notices

- 1. Since mishandling of semiconductor devices may cause malfunctions, please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
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- 6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
- 7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Minebea power semiconductor sales department for the latest version of this data sheets
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Minebea POWER SEMICONDUCTORS

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